Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,364	LAI, HAN-CHUNG	
Examiner	Art Unit	
Mike Qi	2871	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East search; US-PGPUB;USPAT;USOCR; EPO;JPO:DERWENT;IBM_TDB; update search (see search history printout)	3/15/2006	
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